

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

First Named Inventor: Luca PUSTERLA, et al §
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Conf. No.: Not Yet Assigned § Group Art Unit: Not Yet Assigned
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Appln. No.: Not Yet Assigned § Examiner: Not Yet Assigned
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Filing Date: Herewith § Attorney Docket No.: 6023-169US
§ (BX2453M)
Title: METHOD FOR MEASURING THE CONCENTRATION OF IMPURITIES IN
HELIUM BY ION MOBILITY SPECTROMETRY

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. §1.97(b)

Enclosed are copies of each of the documents listed on the attached Information Disclosure Citation Form(s) PTO/SB/08A and/or B, which may be material to the patentability of this application and/or for which there may be a duty to disclose in accordance with 37 C.F.R. §1.56.

The enclosed references were cited in an International Search Report (copy enclosed) dated May 13, 2002 from the European Patent Office concerning counterpart International Application No. PCT/IT02/00004. Additional references are also cited and discussed at pages 1 and 7 of the specification.

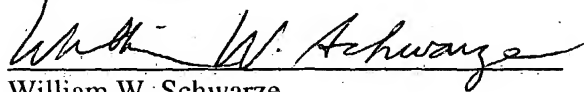
The filing of this Information Disclosure Statement shall not be construed as an admission that any of the listed documents constitutes prior art, nor as an admission against interest in any manner.

No fee is believed to be due in connection with the filing of this Information Disclosure Statement since it is being filed within three months of the filing date of the above-identified application. However, the Commissioner is hereby authorized to charge any deficiencies or credit any overpayments to Deposit Account No. 50-1017.

It is respectfully requested that this Information Disclosure Statement and the documents listed on the attached Form PTO/SB/08A and/or B be considered and acknowledged by the Examiner in connection with the above-identified patent application, be made of record therein, and that the listed document(s) be cited in the issued patent.

Respectfully submitted,

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WWS:sm
Enclosures

Form PTO/SB/08A		Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)		Application Number	Not Yet Assigned
		Filing Date	Herewith
		First Named Inventor	Luca PUSTERLA, et al
		Group Art Unit	Not Yet Assigned
		Examiner Name	Not Yet Assigned
Sheet 1 of 1	Attorney Docket Number	6023-169US (BX2453M)	

U.S. PATENT DOCUMENTS				
Exr Initials	U.S. Patent Document		Name of First Inventor of Cited Document	Date of Publication of Cited Document MM-YYYY
	Number	Kind Code (if known)		
	5,541,519		STEARNS et al.	07-1996
	5,457,316		COHEN et al.	10-1995
	5,955,886		COHEN et al.	09-1999
	4,942,019		GOODELL et al.	07-1990
	5,080,875		BERNAUER	01-1992
	5,182,089		BERNAUER	01-1993
	5,238,469		BRIESACHER	08-1993
	5,492,682		SUCCI et al.	02-1996
	5,556,603		SUCCI et al.	09-1996
	5,558,844		SUCCI et al.	09-1996
	5,968,468		SUCCI et al.	10-1999
	5,716,588		VERGANI et al.	02-1998

FOREIGN PATENT DOCUMENTS						
Exr Initials	Foreign Patent Document			Name of Applicant of Cited Document	Date of Publication of Cited Document MM-YYYY	T ₁
	Country Code	Number	Kind Code (if known)			
	EP	0 470 936	B1	SAES GETTERS S.p.A.	2-1992	X
	WO	00/52432	A3	MASSACHUSETTS INSTITUTE OF TECHNOLOGY	09-2000	X
	EP	1 154 268	A2	AIR PRODUCTS AND CHEMICALS, INC.	11-2001	X
	EP	0 484 301	B1	SAES GETTERS S.p.A.	10-1994	X
	EP	0 493 347	B1	SAES GETTERS S.p.A.	05-1997	X
	EP	0 960 647	A1	SAES GETTERS S.p.A.	12-1999	X

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS		
Exr Initials	Include Name of first Author (in CAPITAL LETTERS), title of the article (where appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), volume-issue number(s), page(s), date (in parentheses). If a book, also include publisher and city and/or county where published.	T ₁

Examiner Signature		Date Considered	
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